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| APPLICATION NO. | FI | LING DATE | FIRST NAMED INVENTOR | ATTORNEY DOCKET NO. | CONFIRMATION NO. | |
|-----------------|-----------------------|--------------------------|----------------------|---------------------|------------------|--|
| 10/646,897 | 10/646,897 08/22/2003 | | Warren M. Farnworth | 01-1059.1 | 1324 | |
| 22823 | 7590 | 06/29/2006 | | EXAMINER | | |
| STEPHEN | | | LEWIS, MONICA | | | |
| 2764 SOUT | |)F STEVE GRATTO! NWAY | ART UNIT | PAPER NUMBER | | |
| LAKEWOO | D, CO 8 | 80228 | 2822 | | | |

DATE MAILED: 06/29/2006

Please find below and/or attached an Office communication concerning this application or proceeding.

| | | Appli | cation No. | Applicant(s) | | | | | |
|---|--|---|--|---|------------------|--|--|--|--|
| Office Action Summary | | | 6,897 | FARNWORTH E | FARNWORTH ET AL. | | | | |
| | | | iner | Art Unit | | | | | |
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| Period fo | The MAILING DATE of this communi or Reply | cation appears or | the cover sheet | t with the correspondence a | ddress | | | | |
| WHIC - Exter after - If NO - Failu Any | ORTENED STATUTORY PERIOD FOR CHEVER IS LONGER, FROM THE MASSIANS OF THE MASSIA | AILING DATE OF of 37 CFR 1.136(a). In runication. Itutory period will apply a will, by statute, cause the | THIS COMMU no event, however, may and will expire SIX (6) No a application to become | NICATION. y a reply be timely filed MONTHS from the mailing date of this of the ABANDONED (35 U.S.C. § 133). | | | | | |
| Status | | | | | | | | | |
| 1)[| Responsive to communication(s) file | d on <i>13 Anril 200</i> | 6 | | • | | | | |
| 2a)□ | • | 2b)⊠ This action | | | | | | | |
| <i>,</i> — | | • | | natters, prosecution as to th | e merits is | | | | |
| اسارت | Since this application is in condition for allowance except for formal matters, prosecution as to the merits is closed in accordance with the practice under <i>Ex parte Quayle</i> , 1935 C.D. 11, 453 O.G. 213. | | | | | | | | |
| | Sicola in accordance with the practic | oo anaon an panto | - quuy,o, 1000 (| | , , | | | | |
| Dispositi | on of Claims | | | | | | | | |
| 4)⊠ | Claim(s) 170-179 and 262-272 is/are | pending in the a | pplication. | | | | | | |
| | 4a) Of the above claim(s) is/are withdrawn from consideration. | | | | | | | | |
| 5)[| Claim(s) is/are allowed. | | | | | | | | |
| 6)⊠ | ☑ Claim(s) <u>170-179 and 262-272</u> is/are rejected. | | | | | | | | |
| 7) | Claim(s) is/are objected to. | | | | | | | | |
| 8)□ | Claim(s) are subject to restric | tion and/or election | on requirement. | | | | | | |
| Applicati | on Papers | | | | | | | | |
| 9)□ | The specification is objected to by the | e Examiner. | | | | | | | |
| , | | | epted or b)⊠ ob | piected to by the Examiner. | | | | | |
| ,, | 10)⊠ The drawing(s) filed on <u>13 April 2006</u> is/are: a) accepted or b)⊠ objected to by the Examiner. Applicant may not request that any objection to the drawing(s) be held in abeyance. See 37 CFR 1.85(a). | | | | | | | | |
| | Replacement drawing sheet(s) including the correction is required if the drawing(s) is objected to. See 37 CFR 1.121(d). | | | | | | | | |
| 11) | The oath or declaration is objected to | | • | | | | | | |
| , | | - , | | | | | | | |
| Priority u | ınder 35 U.S.C. § 119 | | | | | | | | |
| 12) Acknowledgment is made of a claim for foreign priority under 35 U.S.C. § 119(a)-(d) or (f). a) All b) Some * c) None of: 1. Certified copies of the priority documents have been received. 2. Certified copies of the priority documents have been received in Application No 3. Copies of the certified copies of the priority documents have been received in this National Stage application from the International Bureau (PCT Rule 17.2(a)). * See the attached detailed Office action for a list of the certified copies not received. | | | | | | | | | |
| 2) Notic 3) Inform | e of References Cited (PTO-892) e of Draftsperson's Patent Drawing Review (P nation Disclosure Statement(s) (PTO-1449 or r No(s)/Mail Date 4/06. | | Paper I | ew Summary (PTO-413) No(s)/Mail Date of Informal Patent Application (PT | O-152) | | | | |

DETAILED ACTION

1. This office action is in response to the request for continued examination filed April 13, 2006.

Continued Examination Under 37 CFR 1.114

2. A request for continued examination under 37 CFR 1.114, including the fee set forth in 37 CFR 1.17(e), was filed in this application after final rejection. Since this application is eligible for continued examination under 37 CFR 1.114, and the fee set forth in 37 CFR 1.17(e) has been timely paid, the finality of the previous Office action has been withdrawn pursuant to 37 CFR 1.114. Applicant's submission filed on 4/13/06 has been entered.

Response to Arguments

3. Applicant's arguments with respect to claims 170-179 and 262-272 have been considered but are most in view of the new ground(s) of rejection.

Specification

4. The lengthy specification has not been checked to the extent necessary to determine the presence of all possible minor errors. Applicant's cooperation is requested in correcting any errors of which applicant may become aware in the specification.

Drawings

5. The drawings are objected to under 37 CFR 1.83(a). The drawings must show every feature of the invention specified in the claims. Therefore, the following must be shown or the feature(s) canceled from the claim(s): a) pin one indicators (See Claims 266 and 267). No new matter should be entered.

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Corrected drawing sheets in compliance with 37 CFR 1.121(d) are required in reply to the Office action to avoid abandonment of the application. Any amended replacement drawing sheet should include all of the figures appearing on the immediate prior version of the sheet, even if only one figure is being amended. The figure or figure number of an amended drawing should not be labeled as "amended." If a drawing figure is to be canceled, the appropriate figure must be removed from the replacement sheet, and where necessary, the remaining figures must be renumbered and appropriate changes made to the brief description of the several views of the drawings for consistency. Additional replacement sheets may be necessary to show the renumbering of the remaining figures. Each drawing sheet submitted after the filing date of an application must be labeled in the top margin as either "Replacement Sheet" or "New Sheet" pursuant to 37 CFR 1.121(d). If the changes are not accepted by the examiner, the applicant will be notified and informed of any required corrective action in the next Office action. The objection to the drawings will not be held in abeyance.

Election/Restrictions

6. Newly submitted claim 272 is directed to an invention that is independent or distinct from the invention originally claimed for the following reasons: a) it is directed to an alternate embodiment (See Page 32 Lines 20-22). The claims that were previously worked on are directed to a patentably distinct embodiment from that of claim 272.

Since applicant has received an action on the merits for the originally presented invention, this invention has been constructively elected by original presentation for prosecution on the merits. Accordingly, claim 272 is withdrawn from consideration as being directed to a non-elected invention. See 37 CFR 1.142(b) and MPEP § 821.03.

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Claim Rejections - 35 USC § 103

- 7. The following is a quotation of 35 U.S.C. 103(a) which forms the basis for all obviousness rejections set forth in this Office action:
 - (a) A patent may not be obtained though the invention is not identically disclosed or described as set forth in section 102 of this title, if the differences between the subject matter sought to be patented and the prior art are such that the subject matter as a whole would have been obvious at the time the invention was made to a person having ordinary skill in the art to which said subject matter pertains. Patentability shall not be negatived by the manner in which the invention was made.
- 8. Claims 170, 171, 174-177, 262-264, 268 and 270 are rejected under 35 U.S.C. 103(a) as obvious over Wakabayashi et al. (U.S. Patent No. 6,607,970) in view of Kinsman et al. (U.S. Patent No. 6,717,245) and Farnworth et al. (U.S. Patent No. 6,620,731).

In regards to claim 170, Wakabayashi discloses the following:

- a) a semiconductor die (1) having an outline, circuit side, a back side, four peripheral edges, and a plurality of die contacts on the circuit side (For Example: See Figure 15);
- b) a plurality of contact bumps (6) on the die contacts (For Example: See Figure 15);
- c) a first polymer layer (13) covering the circuit side, the contact bumps and the peripheral edges, the first polymer layer having edge polymer layers of a selected thickness on the peripheral edges (For Example: See Figure 15); and
- d) a second layer (17) covering the back side, the first polymer layer and the second polymer layer encapsulating the die on six sides such that the component has a chip scale outline corresponding to the outline of the die plus the selected thickness of the edge polymer layers (For Example: See Figure 15).

In regards to claim 170, Wakabayashi fails to disclose the following:

a) a thinned die.

However, Farnworth et al. ("Farnworth") discloses a semiconductor device that has a thinned die (For Example: See Column 8 Lines 61-67). It would have been obvious to one having ordinary skill in the art at the time the invention was made to modify the semiconductor

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of Wakabayashi to include a thinned die as disclosed in Farnworth because it aids in exposing conductive members (For Example: See Column 8 Lines 61-67).

Additionally, since Wakabayashi and Farnworth are both from the same field of endeavor, the purpose disclosed by Farnworth would have been recognized in the pertinent art of Wakabayashi.

b) a plurality of terminal contacts on the contact bumps.

However, Kinsman et al. ("Kinsman") discloses a semiconductor device that has a plurality of terminal contacts (32) on the contact bumps (20) (For Example: See Figure 2). It would have been obvious to one having ordinary skill in the art at the time the invention was made to modify the semiconductor of Wakabayashi to include a plurality of terminal contacts on the contact bumps as disclosed in Kinsman because it aids in providing external connections (For Example: See Column 5 Line 10).

Additionally, since Wakabayashi and Kinsman are both from the same field of endeavor, the purpose disclosed by Kinsman would have been recognized in the pertinent art of Wakabayashi.

In regards to claim 171, Wakabayashi fails to disclose the following:

a) the die is initially contained on a semiconductor wafer and is tested and burned in on the wafer.

Finally, the following limitation makes it a product by process claim: a) "the die is initially contained on a semiconductor wafer and is tested and burned in on the wafer." The MPEP § 2113, states, "Even though product -by[-] process claims are limited by and defined by the process, determination of patentability is based upon the product itself. The patentability of a product does not depend on its method of production. If the product in product-by-process claim

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is the same as or obvious from a product of the prior art, the claim is unpatentable even though the prior product is made by a different process." *In re Thorpe*, 227 USPQ 964, 966 (Fed. Cir. 1985)(citations omitted).

A "product by process" claim is directed to the product per se, no matter how actually made, In re Hirao and Sato et al., 190 USPQ 15 at 17 (CCPA 1976) (footnote 3). See also In re Brown and Saffer, 173 USPQ 685 (CCPA 1972): In re Luck and Gainer, 177 USPQ 523 (CCPA 1973); In re Fessmann, 180 USPQ 324 (CCPA 1974); and In re Marosi et al., 218 USPQ 289 (CAFC 1983) final product per se which must be determined in a "product by, all of" claim, and not the patentability of the process, and that an old or obvious product, whether claimed in "product by process" claims or not. Note that Applicant has the burden of proof in such cases, as the above caselaw makes clear.

In regards to claim 174, Wakabayashi discloses the following:

a) the first polymer layer and the contacts bumps have a same planar surface (For Example: See Figure 15).

In regards to claim 175, Wakabayashi discloses the following:

a) the second polymer layer has a planar second surface (For Example: See Figure 15).

In regards to claim 176, Wakabayashi fails to disclose the following:

a) a plurality of conductive vias in the thinned die electrical in communication with the die contacts and with the terminal contacts.

However, Farnworth discloses a semiconductor device that utilizes a plurality of conductive vias (30) in the die electrical communication with contacts (38) (For Example: See Figures 1A-1G and Column 4 Lines 1-4). It would have been obvious to one having ordinary skill in the art at the time the invention was made to modify the semiconductor of Wakabayashi

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to include a plurality of conductive vias as disclosed in Farnworth because it aids in providing electrical communication between the integrated circuit and the contacts (For Example: See Abstract).

Additionally, since Wakabayashi and Farnworth are both from the same field of endeavor, the purpose disclosed by Farnworth would have been recognized in the pertinent art of Wakabayashi.

In regards to claim 177, Wakabayashi fails to disclose the following:

a) a plurality of second die contacts on the second polymer layer in electrical communication with conductive vias.

However, Farnworth discloses a semiconductor device that has a plurality of second die contacts (40) on the second polymer layer (22) in electrical communication with conductive vias (30) (For Example: See Figures 1A-1G). It would have been obvious to one having ordinary skill in the art at the time the invention was made to modify the semiconductor of Wakabayashi to include a plurality of contacts on the polymer layer as disclosed in Farnworth because it aids in providing electrical communication between the integrated circuit and the contacts (For Example: See Abstract).

Additionally, since Wakabayashi and Farnworth are both from the same field of endeavor, the purpose disclosed by Farnworth would have been recognized in the pertinent art of Wakabayashi.

In regards to claim 262, Wakabayashi discloses the following:

a) the backside comprises a planar surface (For Example: See Figure 15).

a) the backside comprises a polished surface (For Example: See Abstract).

In regards to claim 263, Wakabayashi discloses the following:

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Finally, the following limitation makes it a product by process claim: a) "polished surface." The MPEP § 2113, states, "Even though product -by[-] process claims are limited by and defined by the process, determination of patentability is based upon the product itself. The patentability of a product does not depend on its method of production. If the product in product-by-process claim is the same as or obvious from a product of the prior art, the claim is unpatentable even though the prior product is made by a different process." *In re Thorpe*, 227 USPQ 964, 966 (Fed. Cir. 1985)(citations omitted).

A "product by process" claim is directed to the product per se, no matter how actually made, In re Hirao and Sato et al., 190 USPQ 15 at 17 (CCPA 1976) (footnote 3). See also In re Brown and Saffer, 173 USPQ 685 (CCPA 1972): In re Luck and Gainer, 177 USPQ 523 (CCPA 1973); In re Fessmann, 180 USPQ 324 (CCPA 1974); and In re Marosi et al., 218 USPQ 289 (CAFC 1983) final product per se which must be determined in a "product by, all of" claim, and not the patentability of the process, and that an old or obvious product, whether claimed in "product by process" claims or not. Note that Applicant has the burden of proof in such cases, as the above caselaw makes clear.

In regards to claim 265, Wakabayashi fails to disclose the following:

a) the first polymer layer on each edge comprises a portion of a polymer filled trench.

However, Kinsman discloses a semiconductor device that has a polymer filled trench (26) (For Example: See Figure 1D). It would have been obvious to one having ordinary skill in the art at the time the invention was made to modify the semiconductor of Wakabayashi to include a polymer filled trench as disclosed in Kinsman because it aids in providing hermetic sealing (For Example: See Column 6 Lines 38-41).

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Additionally, since Wakabayashi and Kinsman are both from the same field of endeavor, the purpose disclosed by Kinsman would have been recognized in the pertinent art of Wakabayashi.

In regards to claim 268, Wakabayashi fails to disclose the following:

a) the thinned die comprises a tested and burned in die.

Finally, the following limitation makes it a product by process claim: a) "the thinned die comprises a tested and burned in die." The MPEP § 2113, states, "Even though product -by[-] process claims are limited by and defined by the process, determination of patentability is based upon the product itself. The patentability of a product does not depend on its method of production. If the product in product-by-process claim is the same as or obvious from a product of the prior art, the claim is unpatentable even though the prior product is made by a different process." *In re Thorpe*, 227 USPQ 964, 966 (Fed. Cir. 1985)(citations omitted).

A "product by process" claim is directed to the product per se, no matter how actually made, In re Hirao and Sato et al., 190 USPQ 15 at 17 (CCPA 1976) (footnote 3). See also In re Brown and Saffer, 173 USPQ 685 (CCPA 1972): In re Luck and Gainer, 177 USPQ 523 (CCPA 1973); In re Fessmann, 180 USPQ 324 (CCPA 1974); and In re Marosi et al., 218 USPQ 289 (CAFC 1983) final product per se which must be determined in a "product by, all of" claim, and not the patentability of the process, and that an old or obvious product, whether claimed in "product by process" claims or not. Note that Applicant has the burden of proof in such cases, as the above caselaw makes clear.

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In regards to claim 270, Wakabayashi discloses the following:

a) the first polymer layer comprises a first polymer material and the second polymer layer comprises a second polymer material (For Example: See Column 3 Lines 64-65 and Column 5 Lines 32-33).

9. Claims 172, 173 and 264 are rejected under 35 U.S.C. 103(a) as obvious over Wakabayashi et al. (U.S. Patent No. 6,607,970) in view of Kinsman et al. (U.S. Patent No. 6,717,245), Farnworth et al. (U.S. Patent No. 6,620,731) and Farnworth et al. (U.S. Patent No. 6,097,087).

In regards to claim 172, Wakabayashi discloses the following:

a) the contact bumps comprise metal bumps in a dense array.

However, Farnworth et al. ("Farnworth") discloses a semiconductor device that has a bumps in a dense array (For Example: See Column 1 Lines 30-36). It would have been obvious to one having ordinary skill in the art at the time the invention was made to modify the semiconductor of Wakabayashi to include bumps in a dense array as disclosed in Farnworth because it aids in permitting high input/output capability (For Example: See Column 1 Lines 31-37).

Additionally, since Wakabayashi and Farnworth are both from the same field of endeavor, the purpose disclosed by Farnworth would have been recognized in the pertinent art of Wakabayashi.

In regards to claim 173, Wakabayashi discloses the following:

a) the terminal contacts comprise conductive bumps or balls in a grid array.

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However, Farnworth discloses a semiconductor device that has terminal contacts in a grid array (For Example: See Column 1 Lines 30-36). It would have been obvious to one having ordinary skill in the art at the time the invention was made to modify the semiconductor of Wakabayashi to include terminal contacts in a grid array as disclosed in Farnworth because it aids in permitting high input/output capability (For Example: See Column 1 Lines 31-37).

Additionally, since Wakabayashi and Farnworth are both from the same field of endeavor, the purpose disclosed by Farnworth would have been recognized in the pertinent art of Wakabayashi.

In regards to claim 264, Wakabayashi discloses the following:

a) the second polymer layer comprises a tape material.

However, Farnworth discloses a semiconductor device that has tape material (For Example: See Column 1 Lines 25-37). It would have been obvious to one having ordinary skill in the art at the time the invention was made to modify the semiconductor of Wakabayashi to include tape material as disclosed in Farnworth because it aids in providing flexible material (For Example: See Column 1 Lines 25-37).

Additionally, since Wakabayashi and Farnworth are both from the same field of endeavor, the purpose disclosed by Farnworth would have been recognized in the pertinent art of Wakabayashi.

In regards to claim 265, Wakabayashi fails to disclose the following:

a) the first polymer layer on each edge comprises a portion of a polymer filled trench.

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However, Kinsman discloses a semiconductor device that has a polymer filled trench (26) (For Example: See Figure 1D). It would have been obvious to one having ordinary skill in the art at the time the invention was made to modify the semiconductor of Wakabayashi to include a polymer filled trench as disclosed in Kinsman because it aids in providing hermetic sealing (For Example: See Column 6 Lines 38-41).

Additionally, since Wakabayashi and Kinsman are both from the same field of endeavor, the purpose disclosed by Kinsman would have been recognized in the pertinent art of Wakabayashi.

10. Claim 178 is rejected under 35 U.S.C. 103(a) as obvious over Wakabayashi et al. (U.S. Patent No. 6,607,970) in view of Kinsman et al. (U.S. Patent No. 6,717,245), Farnworth et al. (U.S. Patent No. 6,620,731) and Akram (U.S. Patent No. 6,544,821).

In regards to claim 178, Wakabayashi fails to disclose the following:

a) the second polymer layer comprises a photopolymer.

However, Akram discloses a semiconductor device that utilizes a photopolymer (For Example: See Column 7 Line 31). It would have been obvious to one having ordinary skill in the art at the time the invention was made to modify the semiconductor of Wakabayashi to include a photopolymer layer as disclosed in Akram because it aids in protecting the device (For Example: See Column 7 Lines 31 and 32).

Additionally, since Wakabayashi and Akram are both from the same field of endeavor, the purpose disclosed by Akram would have been recognized in the pertinent art of Wakabayashi.

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11. Claim 179 is rejected under 35 U.S.C. 103(a) as obvious over Wakabayashi et al. (U.S. Patent No. 6,607,970) in view of Kinsman et al. (U.S. Patent No. 6,717,245), Farnworth et al. (U.S. Patent No. 6,620,731) and Gilleo et al. (U.S. Patent No. 6,228,678).

In regards to claim 179, Wakabayashi fails to disclose the following:

a) the second polymer layer comprises a wafer level underfill.

However, Gilleo et al. ("Gilleo") discloses a semiconductor device that has underfill material (For Example: See Column 4 Lines 17 and 18). It would have been obvious to one having ordinary skill in the art at the time the invention was made to modify the semiconductor of Wakabayashi to include underfill as disclosed in Gilleo because it aids in minimizing thermal fatigue (For Example: See Column 1 Lines 60-66).

Additionally, since Wakabayashi and Gilleo are both from the same field of endeavor, the purpose disclosed by Gilleo would have been recognized in the pertinent art of Wakabayashi.

12. Claims 266 and 267 are rejected under 35 U.S.C. 103(a) as obvious over Wakabayashi et al. (U.S. Patent No. 6,607,970) in view of Kinsman et al. (U.S. Patent No. 6,717,245), Farnworth et al. (U.S. Patent No. 6,620,731) and Hembree et al. (U.S. Patent No. 6,313,651).

In regards to claim 266, Wakabayashi fails to disclose the following:

a) the second polymer layer includes at least one pin one indicator.

However, Hembree et al. ("Hembree") discloses a semiconductor device that has a pin one indicator (For Example: See Column 3 Lines 8-18). It would have been obvious to one having ordinary skill in the art at the time the invention was made to modify the semiconductor of Wakabayashi to include a pin one indicator as disclosed in Hembree because it aids in providing orientation verification (For Example: See Column 3 Lines 8-18).

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Additionally, since Wakabayashi and Hembree are both from the same field of endeavor, the purpose disclosed by Hembree would have been recognized in the pertinent art of Wakabayashi.

In regards to claim 267, Wakabayashi fails to disclose the following:

a) the second polymer layer includes at least one pin one indicator.

However, Hembree discloses a semiconductor device that has a pin one indicator (For Example: See Column 3 Lines 8-18). It would have been obvious to one having ordinary skill in the art at the time the invention was made to modify the semiconductor of Wakabayashi to include a pin one indicator as disclosed in Hembree because it aids in providing orientation verification (For Example: See Column 3 Lines 8-18).

Additionally, since Wakabayashi and Hembree are both from the same field of endeavor, the purpose disclosed by Hembree would have been recognized in the pertinent art of Wakabayashi.

13. Claim 269 is rejected under 35 U.S.C. 103(a) as obvious over Wakabayashi et al. (U.S. Patent No. 6,607,970) in view of Kinsman et al. (U.S. Patent No. 6,717,245), Farnworth et al. (U.S. Patent No. 6,620,731) and Lin (U.S. Patent No. 5,436,203).

In regards to claim 269, Wakabayashi fails to disclose the following:

a) the thinned die is contained on a semiconductor wafer having a polymer support dam proximate to edges thereof.

However, Lin discloses a semiconductor device that has a polymer dam (40) (For Example: See Figure 4). It would have been obvious to one having ordinary skill in the art at the time the invention was made to modify the semiconductor of Wakabayashi to include a polymer

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dam as disclosed in Lin because it aids in constraining the flow of the encapsulant (For Example: See Column 4 Lines 66-68).

Additionally, since Wakabayashi and Lin are both from the same field of endeavor, the purpose disclosed by Lin would have been recognized in the pertinent art of Wakabayashi.

14. Claim 271 is rejected under 35 U.S.C. 103(a) as obvious over Wakabayashi et al. (U.S. Patent No. 6,607,970) in view of Kinsman et al. (U.S. Patent No. 6,717,245), Farnworth et al. (U.S. Patent No. 6,620,731) and Functional and Smart Materials by Wang.

In regards to claim 271, Wakabayashi fails to disclose the following:

a) the first polymer layer comprises parylene.

However, Wang discloses a semiconductor device that has parylene (For Example: See 4.2.3). It would have been obvious to one having ordinary skill in the art at the time the invention was made to modify the semiconductor of Wakabayashi to include parylene as disclosed in Wang because it aids in providing high reliability (For Example: See 4.2.3).

Additionally, since Wakabayashi and Wang are both from the same field of endeavor, the purpose disclosed by Wang would have been recognized in the pertinent art of Wakabayashi.

Conclusion

15. Any inquiry concerning this communication or earlier communications from the examiner should be directed to Monica Lewis whose telephone number is 571-272-1838.

If attempts to reach the examiner by telephone are unsuccessful, the examiner's supervisor, Zandra Smith can be reached on 571-272-2429. The fax phone number for the organization

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where this application or proceeding is assigned is 571-273-8300 for regular and after final communications.

ML

June 25, 2006

All